

FORM PTO-1449 U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		ATTY. DOCKET NO.		SERIAL NO.			
		U 016442-2					
		APPLICANT					
		Satoru TANAKA et al.					
		FILING DATE		GROUP			
U.S. PATENT DOCUMENTS							
EXAMINER INITIALS	REFERENCE DESIGNATION	DOCUMENT NUMBER	DATE	NAME	FILING DATE IF APPROPRIATE		
	AA	2003/0018918	01/2003	Natsuno et al.			
	AB						
	AC						
	AD						
	AE						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION <table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 50%;">YES</td> <td style="width: 50%;">NO</td> </tr> </table>	YES	NO
YES	NO						
	AL	2003-258856	09/2003	JP	<table border="1" style="width: 100%; border-collapse: collapse;"><tr><td style="width: 50%;"></td><td style="width: 50%; text-align: center;">X</td></tr></table>		X
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	AM	2003-85084	03/2003	JP	<table border="1" style="width: 100%; border-collapse: collapse;"><tr><td style="width: 50%;"></td><td style="width: 50%; text-align: center;">X</td></tr></table>		X
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	AN	2001-209611	08/2001	JP	<table border="1" style="width: 100%; border-collapse: collapse;"><tr><td style="width: 50%;"></td><td style="width: 50%; text-align: center;">X</td></tr></table>		X
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	AO	02/39294	05/2002	WO	<table border="1" style="width: 100%; border-collapse: collapse;"><tr><td style="width: 50%;"></td><td style="width: 50%; text-align: center;">X</td></tr></table>		X
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	AP				<table border="1" style="width: 100%; border-collapse: collapse;"><tr><td style="width: 50%;"></td><td style="width: 50%;"></td></tr></table>		
OTHER ART (Including Author, Title, Date, Pertinent Dates, Etc.)							
	AQ	Patent Abstracts of Japan of 2003-258856 dated September 12, 2003					
	AR	Patent Abstracts of Japan of 2003-85084 dated March 20, 2003					
	AS	Patent Abstracts of Japan of 2001-209611 dated August 3, 2001					
EXAMINER /Michael Vaughan/			DATE CONSIDERED 09/30/2008				
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